CRystal Test Fixtures

(Leaded, SMD, and Crystal Blank applications)

**Leaded Device Test Fixtures**

- Test Fixtures for leaded devices contain a simple test socket
- Crystal leads fit into separate contact ports
- PI Network test fixtures conform to IEC-444 standards
- Available fixture impedances include 12.5 Ohms, 50 Ohms, and 750 Ohms
- Proprietary 1000K Ohm test fixture provides fast measurements for all crystals in the 10 KHz to 300 KHz range

**SMD Test Fixtures**

- Part adapters accommodate various SMD packages (1.0x0.8 mm to 5x7 mm, HC-49SMD, and custom packages)
Blank Test Fixtures

- Fixtures available for plated and raw blanks

Reflection Test Fixture

- Single SMA connection adapts to user-supplied fixture
- One side of crystal is connected to RF ground
- Applications include crystal wafer probing systems